

UCRL-JRNL-229819



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April 10, 2007

Canadian Journal of Physics

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The importance of EBIT data for Z-pinch plasma diagnostics

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PACS: 32.30.Rj, 52.58.Lq, 52.70.La

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Abstract

The results from the last si x years of x-ray spectrosc opy and spectropolarim etry of high energy density Z-pinch plasm as complemented by experiments with the electron beam ion trap (EBIT) at the Lawrence Livermore National Laboratory (LLNL) are presented. T he two topics discussed are the development of M-shell xray W spectroscopic diagnosti cs and K-shell Ti spectr opolarimetry of Z-pinch plasmas. The main focus is on radiation from a specific load configuration called an "X-pinch". X-pinches are excellent sources for testing new spectral diagnostics and for atom ic modelling b ecause of the high density and temperature o f the pin ch plasmas, which scale from a few µm to several mm in size. They offer a variety of load configurations, which differ in wire connections, number of wires, and wire materials. In this work the study of X-pi nches with tungsten wires combined with wires from other, lower-Z m aterials is reported. Utilizing data produced with the LLNL EBIT at different energies of the electron beam the theore tical prediction of line positions and intensity of M-shell W spectra were tested and calib rated. Polarization-sensitive X-pinc h experim ents at the University of Nevada, Reno (UNR) provide experimental evidence for the existence of strong electron beam s in Ti and Mo X-pinch plasm as and m otivate the development of x-ray spectropolarimetry of Z-pinch plasmas. This diagnostic is based on the measurement of spectra recorded simultaneously by two spectrometers with different sensitivity to the linear polarization of the observed lines and compared with theoretical models of polarization-dependent spectra . Polarization-dependent K- shell spectra f rom Ti Xpinches are presented and com pared with m odel ca lculations and with spec tra generated by a quasi-Maxwellian electron beam at the LLNL EBIT-II e lectron beam ion trap.

1. Introduction

The first x-ray spectra o f M-shell W we re produced by high-density exploded-wire plasmas more than 25 years ago [1]. The precision of the measurements of Ni-like W lines was improved in laser plasma experiments [2]. The extended analysis of Ni-like W spectra from laser plasm a has included $nf\rightarrow 3d$ (n=5-9), $nd\rightarrow 3p$ (n=4-6), and $np\rightarrow 3s$ (n=4,5) transitions [3]. Tungsten wire arrays were studied extensively on the Z accelerator at Sandia National Laborator ies (SNL) since 1998 when i t was shown that they can produce x-ray powers up to 200 TW and x-ray energies up to 2 MJ [4-5]. Since then, despite an increasing num ber of papers about the im plosions of W arrays on the SNL-Z machine and their recent t applications to inertia 1 confinement fusion [6-7], x-ray M-shell diagnostics of tungsten HED plasm as have not yet been developed.

In this paper we present a theoretical model of M-shell W spectra. This model was benchm arked with LLNL EBIT data pr oduced at different en ergies of the electron b eam and record ed b y crys tal spectrom eters and a broadban d microcalorimeter. Moreover, high tem perature and density plasm as were produced from the variety X-pinches on 1 MA Zebra device at UNR. In particular, M-shell W radiation w as generated by the implosions of X-pinches with tungsten wires combined with the wires from other lower-Z wire material such as Al and Mo. These data are also presented.

An X-pinch plasm a is for med by touch-crossing two wires between the electrodes of a high-current pulsed power generator. The current quickly vaporizes and strongly ionizes the wire material. As a result, an X-pinch yields short x-ray bursts from one or more small bright spots at the intersection of the crossed wires. X-pinches are a good source for studying the dynamics of Z-pinch plasmas of very

small sizes, high densities, and tem peratures for developing 1-10keV x-ray backlighters.

Currently, x-ray spectra of X-pinches are collected and studied at dif ferent pulsed power machines, for exam ple, at the university-scale 1 MA Zebra device at University of Nevada, Reno [8-12] and Cobr a facility at Cornell University (CU) [11-12], as well as at smaller devices such as at a 450 kA pulsed power device at CU [13]. It was shown that X-pinch plasm a can r each tem peratures of 2-3 keV and densities up to 10²³ cm⁻³. Another distinct feature of X-pinches is the existence of plasma anisotropy in the form of strong electron beams, which makes them attractive objects for spectropolarim etry (a powerful tool for studying the anisotropy of high temperature plasmas).

Because of the high temperature and density polarized emission from X-pinch plasma is complicated and we first investig ated the polarization properties of K-shell Ti lines using the LLNL EBIT . EBIT is very important for the study of polarization because it is capable o f producing x-ray lines by the beam of non-Maxwellian electrons at well-contro lled experimental conditions, which includes, for exa mple, selection of the atomic process, ionization stage, and value of the electron beam. Our previous w ork on x-ray line polarization at L LNL EBIT included the study of polarization-dependent spectra of x-ray diel ectronic satellites of Li- and Be-like [14-15] and B-like Fe ions [16]. In the pres ent paper we analyze polarization-dependent Ti K-shell spectr a gen erated by a quasi-Max wellian e lectron beam at the LLNL EBIT and compare this analysis with K-sh ell spectra from Ti X-pinches obtained at UNR.

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2. M-shell W radiation from LLNL EBIT and UNR X-pinch experiments

2.1. M-shell W model: atomic and plasma physics in the model

Our non-LT E collisional radiative (CR) model of the M-shell W e mission has about 4000 levels, and includes the ground states from all ions from neutral to bare W and a detailed structure for Cr- to Se-like W i ons [11]. Energy level structure and complete ra diative coup ling a s well as a subset of collision al da ta we re ca lculated using the FAC code developed by M. F. Gu [17]. For complete collisional coupling among excited levels, the Van Regemorter approximation was used, which can lead to some overestimation in the electron temperature.

The energies for the excited states for the trans itions 31-41', 31-51'', and 31-61" as well as radiative transition probabilities in Ni-like W were also determined to second order in Relativistic Many Body Perturbation Theory (RMBPT) [18-20]. The calculations start from a clos ed-shell Dirac-Fock potential, and include second-order Coulomb a nd Breit-C oulomb interactions. Electric-dipole m atrix elem ents are calculated in second order for tran sitions from excited states to the g round state. Table 1 lists the atom ic data calculated for the most intense lines in Ni-lik e W specified in LS coupling. In particular , the spectral lines N1-N10 are allowe d electric-dipole (E1) transitions, i.e. transitions of the type 3-6 (N1, N2), 3-5 (N3 and N4), and 3-4 (N5-N10). The spectral lines N11 and N12 are forbidden 3-4 electricquadrupole (E2) transitions . The com parison of RMBPT and FAC atom ic data calculated f or the observable transitions in Ni-like W in Ta ble 1 shows a good agreement.

2.2. Modeling of the M-shell W spectra from the LLNL EBIT

M-shell W spectra prod uced at the LLN L EBIT-I and EBIT-II ele ctron beam ion

traps were collected in two different experiments using a crystal spectrometer and an engineering m odel of the x-ray spectrom eter (XRS) m icrocalorimeter from the Suzaku x-ray satellite m ission. In the experim ents with a crystal spectrom eter on EBIT-II, the M-sh ell W spectra were produced at e leven different value s of the electron beam E_b ranging from 2.4 keV to 4.6 keV. This spectrom eter covered the spectral region from 5 to 6 Å with a spect ral resolution of 2200. The analysis of these spectra was given in [21]. He re we show some of these spectra and m ake a comparison with our new non-LTE models. In particular, the experim ental M-shell W spectra recorded with the crystal spectrom eter and p roduced at $E_b=3.6, 3.9, a nd$ 4.3 keV are presented along with our m odeling results in Figs. 1, 2, and 3, respectively. The Ni-like W lines N6, N7, and N5 dominate the spectra produced at E_b=3.6 and 3.9 keV (see Figs. 1 and 2), and the Cu-like lines Cu1 and Cu2 are much less intense than the Ni- like lines. Moreover, the two M-s hell W spectra are alm ost the same for these two electron beam energies. By contrast, the spectrum at $E_b=4.3$ keV is different (see Fig. 3). Though the sam e three Ni-like lines are still intense, spectral lines from higher ionization stages (Co1, Co2, and Fe1) appear because this electron b eam energy exceeds the ionization potential of Ni- and Co-lik e W. In general, modeling (top) reproduces well the experimental spectra (b ottom) in all three figures as discussed early in [22].

The XRS microcalorim eter as fi elded on EBIT-I was capable of acquiring, filtering, and characterizing x-ray events on 32 independent pixels as describ ed in [23-24]. This spectrom eter calorim eter recorded the spectra in a broad er spectral range (from 3 to 8 Å) and with about 6 times less re solution than the crystal spectrometer. In these experiments only 14 pixels were used, and each pixel functioned sim ply as one of 14 independe nt sp ectrometers. The fourteen M-shell spectra produced at $E_b=3.9$ keV and recorded by the XRS in experim ents on EBIT-I are presented in Fig. 4. This figure de monstrates the good reproducib ility of this device. In Fig. 5 the experim ental spectrum (bottom) from one of the spectra shown in Fig. 4 is presented along with the m odeling (top). This spectrum is similar to the one recorded by the crystal spectrometer in Fig. 2 but covers a broader spectral range from 3 to 9 Å. As a result, it in cludes not only the three lines Ni6, Ni7, and Ni5 but also the other Ni-like lines from Table 1. The theoretical s ynthetic spectrum at the top of Fig. 5 is calculated using the non-LTE kinetic m odel of W with a Gaussian electron distribution function of 50 eV full width half m aximum (FWHM) centered at $E_b=3.9$ keV. This is the same as the one used for the synthetic spectrum in Fig. 2. All twelve lines Ni1-Ni12 are reproduced well by our theory.

2.3. Comparison of the M-shell W spectra from the LLNL EBIT and UNR Xpinches and modeling of the UNR X-pinch experiments

X-pinches with tungsten wires combined with wires from other, lower-Z wire material such as Al and Mo were used in experiments on the 1MA pulsed power generator Z ebra at UN R to produce and study M-shell radiati on from W ions. We have found that using combined X-pinches consisting of one or a few W wires and the rest of the wires from a lower-Z material (such as Mo or Al) provides better quality M-shell W spectra than when using only W wires [11-12]. The experimental Al/W X-pinch spectrum is shown at the top of Fig. 6. It was a planar-loop X-pinch with a 99 μ m Al 5056 wire in the anode loop and a 35 μ m W wire in the cathode loop. The experimental spectrum includes both K-shell radiation from Al and Mg (Al 5056 has 95% Al and 5% Mg) and M-shell radiation from W. The line designation for all K-

shell lines (Al, Mg, and Ti) is the sam e throughout the paper. For example, Al1 is the He_{α} line, Al2 is the Ly_{α} line, and Al3 is the He_{β} line of Al for K-shell Al.

EBIT spectra were very useful in the identification of M-shell W spectra from the implosion of com bined X-pinches. The comparison of the Al/W X-pinch spectrum (Fig. 6, top) with the experimental LLNL EBIT spectrum (Fig. 5 and Fig. 6, bottom) reveals the 3-4 transitions (N5-N10) and 3-5 transitions (N3 and N4) in Ni-like W.

The experimental W/Mo X-pinch spectrum is shown at the top of Fig. 7. It was a planar-loop X-pinch with a 35 µm W wire in the anode loop and a 50 µm Mo wire in the cathode loop. The experimental spectrum includes both L-shell radiation from Mo and M-shell radiation from W. The comparison of the W/Mo X-pinch spectrum (Fig. 7, top) with the experimental LLNL EBIT spectrum (Figs. 5, 6, 7, bottom) reveals the 3-4 transitions (N5-N10). Because 3-5 tran sitions in Ni-lik e W overlap with 2 -3 transitions in L-shell M o, the lines N3 a nd N4 could not be a ssigned to particular peaks in this X-pinch spectrum. Figure 8 shows the M-shell W modeling of the above mentioned combined X-pinch spectra at an electron temperature Te=1 keV, electron density Ne= 10^{21} cm⁻³, and a sm all portion of non-Maxw ellian electrons f=0.03 (for more about the influence of hot electrons on x-ray spectra, see, for example, [25-26]). Modeling describes well the m ost intense peaks and the ratio between 3-5 and 3-4 transitions in Ni-like W. Howe ver, more work is need ed to match the intensitie s of higher and lower ionization stages. It is important to note that forbidden E2 transitions Nill and Nil2, which are present in spect ra from low-density sources, are not observed in the X-pinch spectra.

3. K-shell Ti radiation from the LLNL EBIT and UNR X-pinch experiments

K-shell T i lines im portant for diagnos ing low-density p lasmas are lis ted in Table 2. They include the He-lik e lines, in particular the He α resonance line (w), the intercombination line IC (y), the forbidden lines x and z, and the inner-shell satellite lines of Li-like ions q and r. All these lines are often used in the diagnostics of Ti plasmas from tokamaks [27, 28] and electron beam ion traps [29]. In addition to these lines, the He-like resonance line He β , the H-like resonance line Ly α , the satellite line of Be-like ions (Be) and the "cold" K a lines of Ti are used in the diag nostics of Xpinch plasm as. The data from two polari zation-sensitive experiments at the LLNL EBIT will be considered. The first experiment involved the measurement of x-ray line polarization of K-shell Ti lines excite d by a m onoenergetic beam [30]. The polarization-sensitive x-ray spectrum of He- like Ti was prod uced at the energy ju st above the electron-im pact excitation th reshold, 4800 eV (and thus below the KM M dielectronic resonances). The m easured intensities were simultaneously recorded by spectrometers with a Si (220) crystal, which records an alm ost pure parallel polarization state, and with a Si (110) crystal, which records a m ixture of both polarization states [30]. In the second experim ent the same technique was used, but the K-shell Ti spectra were generated by a quasi-Maxwellian electron beam [31]. The details of the technique for producing a quasi-Maxwellian electron beam and i ts implementation at the L LNL EBIT facility can be found in [32, 33]. I n the second m easured intens ities were simultaneou sly recorded by experiment [31] the spectrometers with a Si (220) crystal (obs erving an alm ost pure parallel polarization state) and with a Ge (11 1) crystal (o bserving a m ixture of both polarization states). The ratios of the relative intensities of K-shell Ti lines from these two LLNL EBIT experiments are listed in Table 3.

3.1. Modeling of x-ray K-shell Ti spectra

In this section we focus on the data fr om the two spectrom eters employing Si (111) and Ge (111) crystals, which are the least sensitive to polarization, i.e. on the ratios I_2 and I₄, respectively (see Table 3). The non-LTE CR Ti m odel was applied to analyze these data (for the d etails of the model, see [25-26]). In F ig. 9 th eoretical synthetic spectra of K-shell Ti are s hown calculated at low density for two different electron distribution functions (EDF): a Gaussian centered at 4.8 keV (gray line) and a describes well th e ra tios an d Maxwellian at T $_{M}$ =2.3 keV (black line). Theory differences in spectra between m onoenergetic (Gaussian) and quasi-Maxwellian beams. For example, the ratios x /w and y/w are m ore than 50% larger for th e Gaussian EDF (I $_2$) than for the Maxwellian EDF (I $_4$) while the ratio z/w is alm ost unchanged. However, the m odeling does not show any line q (Li-like inner-shell satellite at 2.6277 Å) for the Gaussian EDF. It is suppose to be about 30% of the w line according to the experimental ratios in Table 3. This problem is likely related to the fact that the charge balance in EBIT was shifted toward lower charge states in this measurements, and is not a polarization effect.

Now we will consider the K-shell Ti spectra produced by the 1MA pulsed power Zebra generator at UNR. A typical Ti X-pinch spectrum as well as our modeling results using the non-LTE CR Ti m odel mentioned above is shown in Fig. 10. The modeling of the Ti X-pinch spectrum indicates that the emission comes from at least two different regions : a hot dense region and a cool er and probably less dense region. In particular, the synthetic spectrum at the top (Fig. 10a) is calculated at Te=1 keV and Ne = 10^{21} cm⁻³ and represents the region of Ti plasm a with intense He-lik e lines Ti1 (w, He α), Ti1'(y), Ti3 (He β) and the Li-like s atellites Ti3'. The synthetic spectrum in the middle (Fig. 10b) is calculated at Te=2.2 keV and Ne= 10^{22} cm⁻³ and represents the hot and dense reg ion with in tense H-lik e line Ti2 (Ly α) as well as intense He-like lines Ti1 (w, He α) and Ti3 (He). In addition to these two plasma regions, there may be the third region, which is even cooler than the first one. It emits radiation from Li-like, Be-like, and otheorem robust of the r

3.2. Polarization of x-ray line radiation: calculations and applications to the experiments

Ti X-pinch experiments on the 1 MA Zebra at UNR provided experimental evidence of the existence of strong electron beam s. This motivated the development of a new diagnostics, x-ray spectropolarim etry, for i nvestigating the anisotropy of the plasma EDF. X-ray spectropolarimetry is base don the knowledge of the polarization properties of radiation. An excellent test bed for the study of x-ray line polarization and the benchmarking of the polarization-sensitive calculations (as was mentioned in Introduction) is EBIT.

We begin with a calculation of the polarization of lines that will be applied to experiments at the LLN L EBIT and then to X-pinch experiments on Zebra at UNR. Values of the polarization of the most diagnostically important lines were calculated using the FAC code [17] and are presented in Fig. 11 and in Table 4. The lines listed in Table 2 are produced by the electron im pact excitation, and thus their polarization is shown as a function of electron beam en ergy. The polarization of the most intense line w has its m aximum (~60%) near the excitation threshold (~4.7. keV) and then

gradually d ecreases to wards zero and is le ss then 10% at ten tim es threshold. By contrast, the polarization of line y change s non-monotonically with the energy of the electron beam. It is negative near threshold (~-30%), then changes sign and becom es ~+30% already at 3 times threshold. Then it approaches the polarization of the w line. Hence, when the m easured polarization of the w and y lines is the s ame then the energy of electron beam is higher than 30 keV and when it is different then it indicates a low-energy electron beam with the energy close to the threshold or only somewhat higher. This result is im portant in diagnosing the energy of beam s i n plasmas.

In Table 4 the deg ree of polarization for the K-sh ell Ti lines excited by a monoenergetic electron beam with energy of 4.8 and 11.5 keV is given. In particular, the measured values of polarization obtained using the measured intensities (see Table 3) and a two-crystal technique from [30, 35] along with theoretical predictions from [30] are listed for E b=4.8 keV. The ratio of intensities I $_1/I_2$ from Table 3 close to 1 indicates almost equal values of polarization of two lines. For example, this ratio I $_1/I_2$ =0.99 for q/w (see Table 3) and corresponding degrees of polarization for lines w and q are both ~ 0.4 (see Table 4). The ratio of intensities I $_1/I_2$ = 0.75 for z/w and the corresponding degree of polarization of the line z is -0.101. The smallest ratio of I $_1/I_2$ = 0.53 for x/w results in the m ost negative value of polarization of this line (-0.48). Our theoretical values of x -ray line polarization calculated at 4.8 keV agree well with the measured values and the theoretical values from [30].

The theoretical values of polarization calculated at E_b =4.8 keV and 11.5 keV show limits within which the polarization is changing in the experiment with a quasi-Maxwellian electron beam (the second experiment discussed in the beginning of this section). As was discussed before polarizat ion of the line y changes the most (from -

0.308 to +0.228), which m ay result in alm ost zero polarization. Polarization of other lines only slightly changes, in particular decreases for positively polarized lines (w and q) and increases for the negatively polar ized lines (z and x). To e mploy the twocrystal technique we need to m ake an a ssumption about the value of polarization of the certain line. If we assum e the p olarization of the line w is 0.5 th en using th e polarization-sensitive ratios I_3/I_4 for the lines y, z, and x we estim ate polarization of almost zero for the line y ($I_3/I_4 = 0.74$), ~-0.2 for the line z ($I_3/I_4 = 0.63$), and ~-0.48 for the line x ($I_3/I_4 = 0.47$). These values of polarization fall within the corresponding limits from Table 4. They also correlate well with the above analysis of the intensity ratios I_1/I_2 from Table 3. On the contrast, the estimate for polarization of the line q gives a small negative value, which does not agree with our prediction (s ee Table 4). This will be a subject of future work.

In a Maxwellian plasma dielectronic satellite transitions play an important role and several n=2 satellites produced by the processes $1s^2 + e^- \rightarrow 1s2121$ ' and $1s^22s + e^- \rightarrow 1s2s2121$ ' are seen. T his is illustrated in Fig. 12 where we s how the dielectronic satellite spectra of Li-like (line s j, k, s, m, and t) and Be-like Ti recorded by the Si (220) crystal in the experiment with a quasi-Maxwellian electron beam from [36]. The theoretical polarizations-sensitive spectra describe the experiment well. The details of calculations of atom ic and polarization charact eristics of these transitions in Ti ion s are given in [37].

The K-shell line radiation from Ti X- pinches was recorded by a polarim eter, which includes so-called horizontal (H) and vertica 1 (V) spec trometers. The experimental details including the diagnostic setup were described in [38-39]. Briefly, the "H "spectrom eter has a d ispersion plane perpendicular to the dis charge ax is and records mostly the parallel polarization state. The "V" spectrom eter has a dispersion plane parallel to the d ischarge axis and records mostly the p erpendicular polarization state. Both "H" and "V" spectrom eters were two identical co nvex crystal spectrometers utilizing LiF crystals with a lattice spacing (2d=4.027Å) corresponding to nominal Bragg angles from 40.6° (for Ti1 line) up to 42.9 ° (for Ti4 line). Typical spectra recorded by the "H" and "V" spectrom eters are presented in Fig. 13 (shot 39). The experim ental intensity ratios of the K-shell Ti lines with the wavelengths providing the Bragg angle closest to 45° (Ti1, Ti1', Ti1'', Ti1''', and Ti4) are listed in Table 5 for three selected shots where Ti X-pinches were m ade from 30µm Ti wires. The experim ental intensities ratios in Table 5 are associated with different polarization states III/I | for each of the spectral lines from the horizontal and vertical spectra (H/V). A ratio III/I greater (less) than unity for a given line indicates positive (negative) polarization of the line. We belie ve that line polarization occurred in shot 39, where the largest deviations from unity have been observed. For this particular shot, for He-like lines Ti1 and Ti1' the ratio H/V is almost equal and less than 1 (i.e. negative polarization). It indicates the energy of electron beam s higher than 30 keV (see Fig. 11). More experimental data is needed to ref ine this technique to es timate line polarization and energy of electron beams with sufficient accuracy.

In addition to the resonance lines and satellite lines the relative intensities of the "cold" Ti K $_{\alpha}$ line (from wire m aterial) and the "cold" Fe K $_{\alpha}$ line (from the stainless steel anode) were measured [39]. It was shown that the relative intensities of both "cold" lines have their minimum values for shot 39 when the largest polarization was observed. This m eans that observation of strong characteristic lines does not necessarily indicate the presence of electron beams responsible for line polarization. It would be interesting to study the polarization of the "cold" Ti K $_{\alpha}$ line and its application for Z-pinch plasma diagnostics.

4. Conclusion

The development of x-ray diagnostics of Z-pinch plasm as during the last six years was reviewed. This development was focused on the M-shell emission of W and the K-shell emission of Ti. High tem perature and density plasm as were produced from the variety of X-pinches on the 1 MA Zebra device at UNR. In particular, M-shell W radiation was generated by the im plosions of X-pinches with tungsten wire s combined with the wires from other lower-Z wire material such as Al and Mo. Th e M-shell emission of W ions is a very challenging topic for plasma diagnostics because of contributions from numerous ionization stages in a narro w spectral region that is impossible to re solve. LLNL EBIT data p roduced at various b eam energ ies a nd recorded by a high-resolution crystal spect rometer and a broadband m icrocalorimeter allowed us to break down this very com plicated M-shell spectrum into spectra with a limited number of ionization stages. LLNL EB IT data helped not only to identify the spectra from X-pinches but also to benchmark the theoretical modeling.

The results of polarization-sensitive experiments with Ti X-pinches on the Zebra at UNR were also reviewed. It was shown that the difference in polarization-dependent spectra provided information about the existence of electron beams in Z-pinch plasmas. Refinement of the technique should also provide a value of the average energy of the beam s. Polarization-dependent spectra of the Ti K-shell emission generated by a quasi-Maxwellian beam at the LLNL EBIT f acility were studied, and the usefulness of these da ta for x-ray spectropo larimetry was emphasized. Also the importance of the ability of EBIT to simulate a quasi-Maxwellian beam for benchmarking theoretical calculations was demonstrated.

Acknowledgement

This work was supported by NNSA under DOE Cooperative Agreem ent DE-FC52-06NA27588 and in part by DE-FC52-06NA27586 and DE-FC52-06NA27616. Work at UC, LLNL was performed under of auspices of the DOE under contract N o. W-7405-Eng-48.

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Table 1.

Wavelengths (λ in Å) and radiative transition rates (Ar in s⁻¹) for the strongest E1 and E2 transitions from excited states with J=1 and 2 into the ground state in Ni-like W calculated by RMBPT [18-20] and FAC [17] codes.

		RI	RMBT		NC
Line	Upper level LS	λ (Å)	Ar (s ⁻¹)	λ (Å)	Ar (s ⁻¹)
Ni 1	3d6f ¹ D	3 803	5 30[13]	3 805	6 51 [13]
Ni2	$3d6f ^{3}D_{1}$	3.879	5.66[13]	3.880	7.25[13]
Ni3	3d5f ¹ P ₁	4.308	1.16[14]	4.309	1.33[14]
NI4	$3d5f^{3}D_{1}$	4.403	9.07[13]	4.405	1.02[14]
Ni5	$3p4d P_1$	5.201	9.35[13]	5.195	9.54[13]
Ni6	3p4s ¹ P ₁	5.689	3.72[14]	5.686	3.99[14]
Ni7	$3d4f ^{3}D_{1}$	5.870	1.18[14]	5.872	1.24[14]
Ni8	$3d4f ^{3}P_{1}$	6.154	2.21[13]	6.144	2.17[13]
Ni9	$3d4p ^{3}D_{1}$	7.027	1.27[13]	7.028	1.21[13]
Ni10	$3d4p^{3}P_{1}$	7.174	6.67[12]	7.175	6.32[12]
Ni11	$3d4s ^{1}D_{2}$	7.608	4.04[09]	7.610	4.55[09]
Ni12	$3d4s$ $^{3}D_{2}$	7.929	5.32[09]	7.930	5.97[09]

Table 2.

K-shell Ti lin es im portant in the diagn ostics of low-den sity plasmas.

lso- electronic sequence	Line	Transition	λ(Å)	
He-like	w	1s2p $^{1}P_{1} \rightarrow 1s^{2} ^{1}S_{0}$	2.6105	
He-like	x	1s2p ${}^{3}P_{2} \rightarrow 1s^{2} {}^{1}S_{0}$	2.6192	
He-like	У	1s2p ${}^{3}\mathbf{P}_{1} \rightarrow 1s^{2} {}^{1}\mathbf{S}_{0}$	2.6229	
Li-like	q	1s2s2p $^2 extsf{P}_{3/2}$ $ ightarrow$ 1s $^2 extsf{2s}$ $^1 extsf{S}_0$	2.6277	
Li-like	r	1s2s2p $^2P_{1/2}$ $ ightarrow$ 1s ² 2s 1S_0	2.6300	
He-like	z	1s2s ³S ₁ → 1s² ¹S ₀	2.6370	

Table 3.

Ratios of the K-shell T i line intensities from LLNL EBIT experiments produced by a monoenergetic electron beam centered at 4.8 keV and a quasi-Maxwellian electron beam at Te=2.3 keV at LLNL EBIT.

	E _b = monoenerg Si(220)	E _b =4800 eV monoenergetic beam [30] Si(220) Se(111)			T _{max} =2.3 keV quasi-Maxwellian beam [31] Si(220) Ge(111)			
	I,	I_2	I ₁ /I ₂	l ₃	l ₄	I ₃ /I ₄		
y/w	0.147	0.235	0.63	0.113	0.153	0.74		
x/w	0.102	0.191	0.53	0.068	0.145	0.47		
z/w	0.258	0.343	0.75	0.212	0.335	0.63		
q/w	0.313	0.316	0.99	0.184	0.255	0.72		

Table 4.

Comparison of polarization degrees for the K-shell Ti lines excited by monoenergetic electron beams with the energy of 4.8 and 11.5 keV.

		11.5 keV		
	theory[30]	exp[30]	theory	theory
w	+0.608	+0.43 +0.14 -0.12	+0.607	+0.481
У	-0.339	-0.33 +0.07 -0.07	-0.309	+0.228
x	-0.519	- 0.48+ ^{0.06} -0.06	-0.513	-0.418
z	-0.106	-0.101 ^{+0.014} -0.013	-0.106	-0.096
q	+0.341	+0.40 ^{+0.15} -0.1	+0.340	+0.270

Table 5.

Measured values of the intensities of lines recorded by a horizontal (H) and a vertical

(V) spectrometers in Ti X-pinch experiments.

Iso- elect. seq.	Line	Shot 36		Shot 37		Shot 39				
- 1999-C	87	н	v	н/v	н	V	н/v	н	v	н/v
He-like	Ti1(,w)	2.19[7]	1.90[7]	1.15	2.79[7]	2.68[7]	1.04	2.97[7]	3.66[7]	0.81
He-like	Ti1'(y)	1.98[7]	1.58[7]	1.25	2.38[7]	2.08[7]	1.14	2.62[7]	3.21[7]	0.82
Li-like	Ti1''(q)	1.69[7]	1.30[7]	1.30	1.79[7]	1.54[7]	1.16	2.36[7]	2.20[7]	1.07
Be-like	Ti1'''	6.48[6]	5.23[6]	1.24	6.47[6]	5.22[6]	1.24	9.81[6]	7.34[6]	1.34
Low ion.	Ti4(K _a)	2.30[7]	2.24[7]	1.03	1.90[7]	1.64[7]	1.16	1.64[7]	1.43[7]	1.15

Figure Captions

Fig. 1. Exp erimental M-shell spectrum of W ions from the LLNL EBIT-II fac ility recorded by a crystal spectrom eter at $E_b=3.6 \text{ keV}$ (bottom) and theoretical synthetic spectrum calculated for a Gaussian electron distribution function of FWHM=50 eV centered at 3.6 keV (top). Inte nse spectral features are identified by the iso-electronic sequence.

Fig. 2. Exp erimental M-shell spectrum of W ions from the LLNL EBIT-II fac ility recorded by a crystal spectrom eter at $E_b=3.9$ keV (bottom) and theoretical synthetic spectrum calculated for a Gaussian electron distribution function of FWHM=50 eV centered at 3.9 keV (top). Intense spectral features are identified by the iso-electronic sequence.

Fig. 3. Exp erimental M-shell spectrum of W ions from the LLNL EBIT-II fac ility recorded by a crystal spectrom eter at $E_b=4.3 \text{ keV}$ (bottom) and theoretical synthetic spectrum calculated for a Gaussian electron distribution function of FWHM=50 eV centered at 4.3 keV (top). Inte nse spectral features are identified by the iso-electronic sequence.

Fig. 4. The fourteen M-shell spectra of W ions from LLNL EBIT-I device recorded by the 14 pixels of the XRS microcalorimeter at $E_b=3.9$ keV.

Fig. 5. Experim ental M-shell spectrum of W ions from the LLNL EBIT-I device recorded by the XRS m icrocalorimeter at E $_{b}$ =3.9 keV (bottom) and theoretical synthetic s pectrum calculated for a Gauss ian el ectron di stribution function of FWHM=50 eV centered at 3.9 keV (top). Inte nse spectral features are identified by

the iso-electronic sequence.

Fig. 6. Experimental spectrum from the Ze bra Al/W X-pinch (top) and experimental M-shell spectrum of W ions from the LLNL EBIT-I electron ion beam trap recorded by the XRS microcalorimeter at $E_b=3.9$ keV (bottom).

Fig. 7. Experimental spectrum from the Zebra W/Mo X-pinch (top) and experimental M-shell spectrum of W ions from the LLNL EBIT-I electron ion beam trap recorded by the XRS microcalorimeter at $E_b=3.9$ keV (bottom).

Fig. 8. Experim ental com bined Al/W (black) and W /Mo (grey) X-pinch spectra fit with a synthetic spectrum from our m odel at Te=1 keV, Ne= 10^{-21} cm⁻³, and f=0.03 (light grey).

Fig. 9. Theoretical synthetic spectra of K-sh ell Ti calculated at low d ensity for two different electron distribution functions: a Ga ussian of FWHM=50 eV centered at 4.8 keV (grey line) and a Maxwellian at T_M =2.3 keV (black line).

Fig. 10. Theoretical synthetic spectra of K-shell Ti calculate d at Te=1 keV and Ne= 10^{21} cm ⁻³ (a) and at Te=2.2 keV and Ne= 10^{22} cm ⁻³ (b) are used for the interpretation of the typical Ti X-pinch spectrum (c).

Fig. 11. Polarization of the m ost intense K-shell Ti lines as a function of the electron beam energy. Identification of these lines is given in Table 2.

Fig. 12. Com parison of experimental (gre y line) and theoretical (black line) dielectronic recom bination spectra of K- shell Ti. The experimental spectrum was produced on LLNL EBIT recorded with a von Há most ype crystal spectrometer employing a Si (220) crystal.

Fig. 13. Polarization -sensitive K-shell spectra from a Ti X-pinch prod uced at the 1 MA Zebra facility at UNR. The spectra were sim ultaneously recorded by the horizontal (top) and vertical (bottom) spectrometers (Zebra shot 39).



Fig. 1.



Fig. 2.



Fig. 3.





Fig. 5.



Fig. 6.



Fig. 7.



Fig. 8.



Fig. 9.



Fig. 10.



Fig. 11.



Fig. 12.



Fig. 13.